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- **EPIC™** (Enhanced-Performance Implanted **CMOS) Submicron Process**
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 250 mA Per **JESD 17**
- Typical V_{OLP} (Output Ground Bounce) $< 0.8 \text{ V at V}_{CC} = 3.3 \text{ V}, T_A = 25^{\circ}\text{C}$
- Typical V_{OHV} (Output V_{OH} Undershoot) > 2 V at V_{CC} = 3.3 V, T_A = 25°C
- Inputs Accept Voltages to 5.5 V
- **Package Options Include Plastic** Small-Outline (D), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Chip Carriers (FK) and Flat (W) Packages, and DIPs (J)

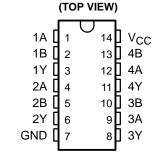
description

These quadruple 2-input positive-AND gates are designed for 2.7-V to 3.6-V V_{CC} operation.

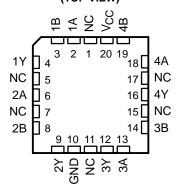
The 'LVC08A devices perform the Boolean function $Y = A \bullet B$ or $Y = \overline{A} + \overline{B}$ in positive logic.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-/5-V system environment.

SN54LVC08A . . . J OR W PACKAGE SN74LVC08A . . . D. DB. OR PW PACKAGE



SN54LVC08A . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

The SN54LVC08A is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74LVC08A is characterized for operation from -40°C to 85°C.

FUNCTION TABLE (each gate)

INPUTS		OUTPUT
Α	В	Υ
Н	Н	Н
L	X	L
Х	L	L



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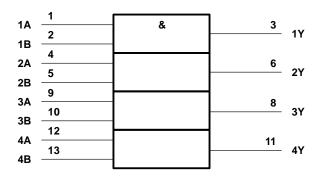
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SN54LVC08A, SN74LVC08A QUADRUPLE 2-INPUT POSITIVE-AND GATES

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logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, DB, J, PW, and W packages.

logic diagram, each gate (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, V _{CC}	0.5 V to 6.5 V
Input voltage range, V _I (see Note 1)	
Output voltage range, VO (see Notes 1 and 2)	0.5 V to V_{CC} + 0.5 V
Input clamp current, $I_{ K }(V_{ C } < 0)$	
Output clamp current, I _{OK} (V _O < 0)	–50 mA
Continuous output current, IO	±50 mA
Continuous current through V _{CC} or GND	±100 mA
Package thermal impedance, θ_{JA} (see Note 3): D package	127°C/W
DB package	158°C/W
PW package	
Storage temperature range, T _{stq}	–65°C to 150°C

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.
 - 2. The value of V_{CC} is provided in the recommended operating conditions table.
 - 3. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 4)

					SN74LVC08A		UNIT	
			MIN	MAX	MIN	MAX	UNIT	
Vcc	Supply voltage	Operating	2	3.6	2	3.6	V	
		Data retention only	1.5		1.5		V	
VIH	High-level input voltage	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2		2		V	
V _{IL}	Low-level input voltage	$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$		0.8		0.8	V	
٧ _I	Input voltage		0	5.5	0	5.5	V	
٧o	Output voltage		0	VCC	0	VCC	V	
lau	High-level output current	$V_{CC} = 2.7 \text{ V}$		-12		-12	mA	
ЮН		$V_{CC} = 3 V$		-24		-24	IIIA	
lOL	Low lovel output ourrent	$V_{CC} = 2.7 \text{ V}$		12		12	mA	
	Low-level output current V _{CC} = 3 V			24		24	ША	
Δt/Δν	Input transition rise or fall rate		0	8	0	8	ns/V	
TA	Operating free-air temperature		-55	125	-40	85	°C	

NOTE 4: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	v _{CC}	SN54LVC08A	SN74LVC08A	UNIT
PARAMETER	TEST CONDITIONS		MIN TYPT MAX	MIN TYPT MAX	UNII
	I _{OH} = -100 μA	2.7 V to 3.6 V	V _{CC} -0.2	V _{CC} -0.2	
VOH	I _{OH} = -12 mA	2.7 V	2.2	2.2	V
	IOH = -15 IIIW	3 V	2.4	2.4	V
	I _{OH} = -24 mA	3 V	2.2	2.2	
	I _{OL} = 100 μA	2.7 V to 3.6 V	0.2	0.2	
V _{OL}	V_{OL} $I_{OL} = 12 \text{ mA}$		0.4	0.4	V
	I _{OL} = 24 mA	3 V	0.55	0.55	
lį	V _I = 5.5 V or GND	3.6 V	±5	±5	μΑ
ICC	$V_I = V_{CC}$ or GND, $I_O = 0$	3.6 V	10	10	μΑ
ΔlCC	One input at V _{CC} – 0.6 V, Other inputs at V _{CC} or GND	2.7 V to 3.6 V	500	500	μΑ
C _i	$V_I = V_{CC}$ or GND	3.3 V	5	5	pF

[†] All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

switching characteristics over recommended operating free-air temperature range, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

	FROM (INPUT)	TO (OUTPUT)	SN54LVC08A			SN74LVC08A					
PARAMETER			V _{CC} = 3.3 V ± 0.3 V		V _{CC} = 2.7 V		V _{CC} = 3.3 V ± 0.3 V		V _{CC} = 2.7 V		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t _{pd}	A or B	Υ	1	4.1		4.8	1	4.1		4.8	ns
t _{sk(o)} ‡								1			ns

[‡] Skew between any two outputs of the same package switching in the same direction.

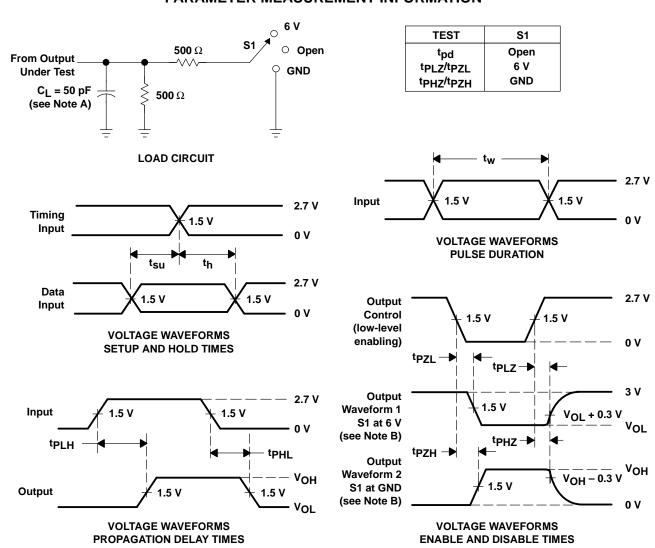


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operating characteristics, V_{CC} = 3.3 V, T_A = 25°C

PARAMETER		TEST CON	TYP	UNIT	
C _{pd}	Power dissipation capacitance per gate	C _L = 50 pF,	f = 10 MHz	10	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, $Z_0 = 50 \Omega$, $t_\Gamma \leq$ 2.5 ns, $t_f \leq$ 2.5 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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